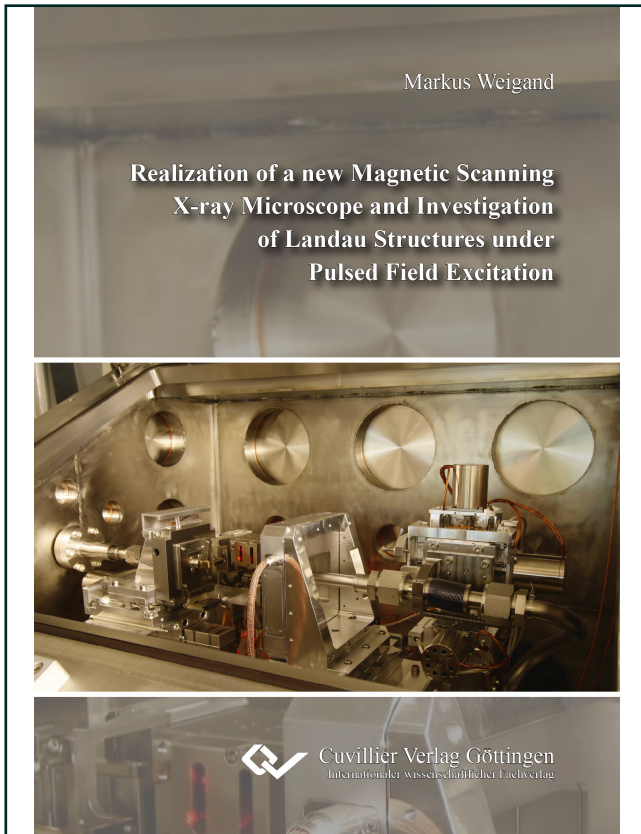




Markus Weigand (Autor)

# Realization of a new Magnetic Scanning X-ray Microscope and Investigation of Landau Structures under Pulsed Field Excitation



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